## Applicant(s)/Patent Under Reexamination Application/Control No. 10/042,491 BROWN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2155 Oanh Duong

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,983,331	01-2006	Mitchell et al.	709/246
*	В	US-2003/0052923	03-2003	PORTER, SWAIN W.	345/790
*	С	US-2002/0194190	12-2002	Shema et al.	707/102
*	D	US-6,687,737	02-2004	Landsman et al.	709/203
*	Е	US-6,886,013	04-2005	Beranek, Michael J.	707/10
*	F	US-2002/0133565	09-2002	Huat, Khoo Soon	709/218
*	G	US-2003/0014445	01-2003	Formanek et al.	707/526
*	Н	US-2002/0147637	10-2002	Kraft et al.	705/14
*	1	US-6,535,912	03-2003	Anupam et al.	709/217
*	J	US-2002/0010626	01-2002	Agmoni, Eyal	705/14
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10177569 A	06-1998	Japan	OZAWA et al.	
	0	JP 2001298723 A	10-2001	Japan	KAWATSUMA, NOBORU	,
	Р	JP 2002182602 A	06-2002	Japan	KAWAGUCHI, TOSHIO	
	Q	JP 2003108468 A	04-2003	Japan	KUZUHARA et al.	
	R					
	s					
	T	·				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.